



501.43354X00

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant: Y. OKUDA, et al.  
Serial No: 10/767,054  
Filed: January 30, 2004  
Title: SEMICONDUCTOR MEMORY DEVICE AND TEST METHOD  
Group: 2138  
Examiner: Guerrier MERANT

**AMENDMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

April 9, 2007

Sir:

In response to the Office Action December 7, 2006, the period of response for which extension is requested by the attached Petition for Extension of Time, please amend the above-identified application as listed below and as set forth on the following pages:

Amendments to the Claims

Remarks are included following the amendments.